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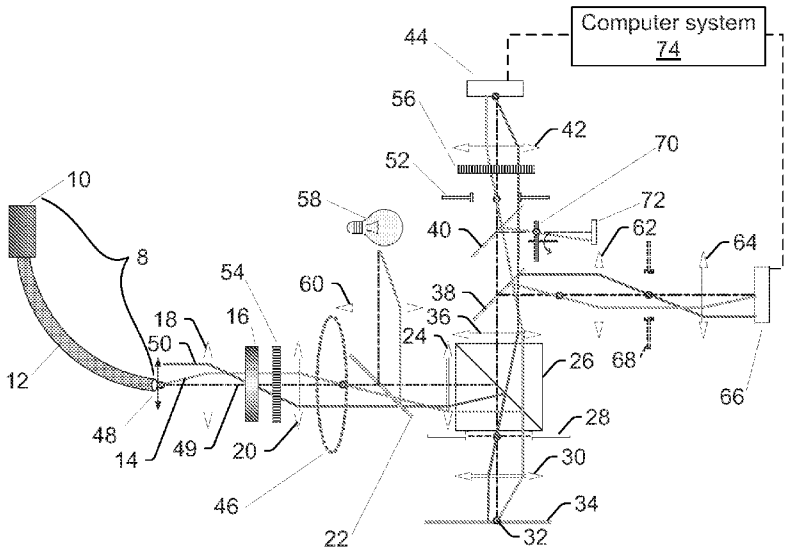


Fig. 1

(57) Abstract: Various metrology systems and methods are provided.

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